

Notice of References Cited	Application/Control No. 10/576,173		Applicant(s)/Patent Under Reexamination FUJITA ET AL.	
	Examiner Christian Y. Jang		Art Unit 4153	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0236235	11-2004	Fujita et al.	600/500
*	B	US-2006/0247542	11-2006	Watanabe et al.	600/500
*	C	US-2002/0156392	10-2002	Arai et al.	600/546
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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